

Depletion-Mode Power MOSFET

General Features

- ESD improved Capability
- Depletion Mode (Normally On)
- Proprietary Advanced Planar Technology
- Rugged Polysilicon Gate Cell Structure
- Fast Switching Speed
- RoHS Compliant
- Halogen-free available

Applications

- Synchronous Rectification
- Normally-on Switches
- Linear Amplifier
- High Voltage Regulator
- Constant Current Source
- Protection Circuits
- ➢ Telecom

Ordering Information

Part Number	Package	Marking	Remark
DMZ1511E	SOT-23	1511	Halogen Free

Absolute Maximum Ratings

$T_A=25^{\circ}C$ unless otherwise specified

		TA=25 C unicss otherwise specified		
Symbol	Parameter	DMZ1511E	Unit	
V _{DSX}	Drain-to-Source Voltage ^[1]	150	V	
V _{DGX}	Drain-to-Gate Voltage ^[1]	150	V	
ID	Continuous Drain Current	0.1		
I _{DM}	Pulsed Drain Current ^[2]	0.4	A	
P _D	Power Dissipation	0.50	W	
V _{GS}	Gate-to-Source Voltage	±20	V	
T_L	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	°C	
T_{J} and T_{STG}	Operating and Storage Temperature Range	-55 to 150		

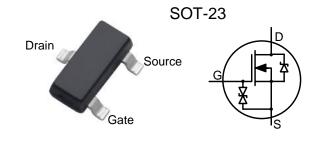
Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	DMZ1511E	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	250	K/W

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BV _{DSX}	RDS(ON) (Max.)	IDSS,min
150V 25 Ω		100mA





Electrical Characteristics

OFF Characteristics

OFF Characteristics					$T_A = 25 \degree C$ unless otherwise specified		
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
BV _{DSX}	Drain-to-Source Breakdown Voltage	150			V	V _{GS} =-5V, I _D =250µA	
	Drain-to-Source Leakage Current			10	μA	V_{DS} =150V, V_{GS} =-5V	
I _{D(OFF)}				1.0	mA	V_{DS} =150V, V_{GS} =-5V T_J =125 °C	
I _{GSS}	Gate-to-Source Leakage Current			20		V_{GS} =+20V, V_{DS} =0V	
				-20	μA	V_{GS} =-20V, V_{DS} =0V	

ON Characteristics

 $T_A = 25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
I _{DSS}	Saturated Drain-to-Source Current	100			mA	V _{GS} =0V, V _{DS} =25V
R _{DS(ON)}	Static Drain-to-Source On-Resistance			25	Ω	$V_{GS}=0V$, $I_D=50mA^{[3]}$
V _{GS(OFF)}	Gate-to-Source Cut-off Voltage	-3.3		-1.5	V	$V_{DS}=3V, I_D=8\mu A$
gfs	Forward Transconductance		0.24		S	V _{DS} =10V, I _D =50mA

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{ISS}	Input Capacitance		12.8		pF	$\begin{array}{l} V_{GS} = -10V \\ V_{DS} = 25V \\ f = 1.0MH_Z \end{array}$
Coss	Oput Capacitance		5.4			
C _{RSS}	Reverse Transfer Capacitance		3.3			
Q _G	Total Gate Charge		3		nC	V _{GS} =-10V~0V V _{DS} =75V, I _D =100mA
Q _{GS}	Gate-to-Source Charge		0.23			
Q _{GD}	Gate-to-Drain (Miller) Charge		1.1			

Resistive Switching Characteristics			Essentially independent of operating temperatur			
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
$t_{d(ON)}$	Turn-on Delay Time		7		ns	$V_{GS}=-10V\sim0V$ $V_{DD}=75V, I_{D}=100mA$ $R_{G}=20\Omega$
t _{rise}	Rise Time		16			
t _{d(OFF)}	Turn-off Delay Time		25			
t_{fall}	Fall Time		120			



Source-Drain Diode Characteristics

 $T_A=25^{\circ}C$ unless otherwise specified

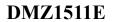
Symbol	Parameter	Min	Тур.	Max.	Units	Test Conditions
V _{SD}	Diode Forward Voltage			1.2	V	I_{SD} =100mA, V_{GS} =-5V

NOTE:

[1] $T_J = +25^{\circ}C$ to $+150^{\circ}C$

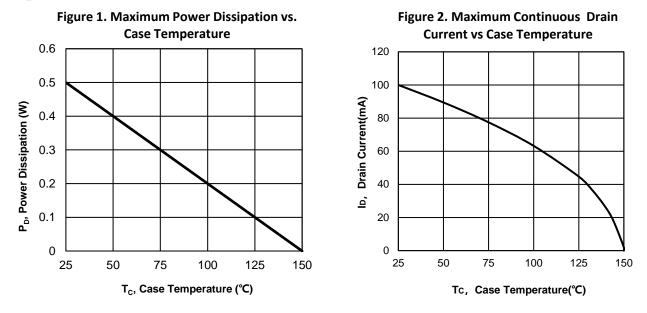
[2] Repetitive rating, pulse width limited by maximum junction temperature.

[3] Pulse width \leq 380µs; duty cycle \leq 2%.



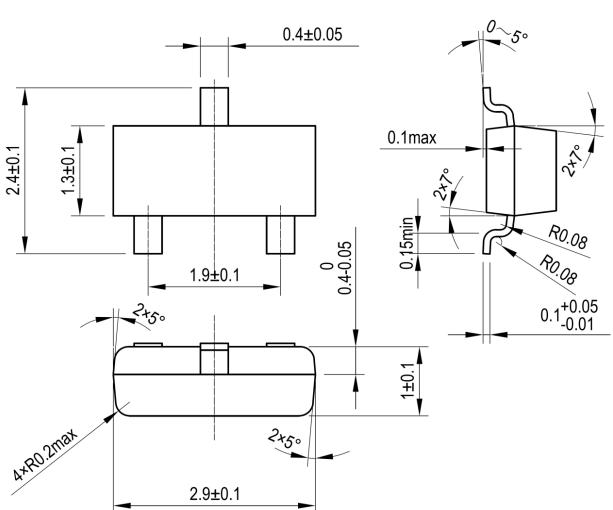
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Typical Characteristics



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SOT-23

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